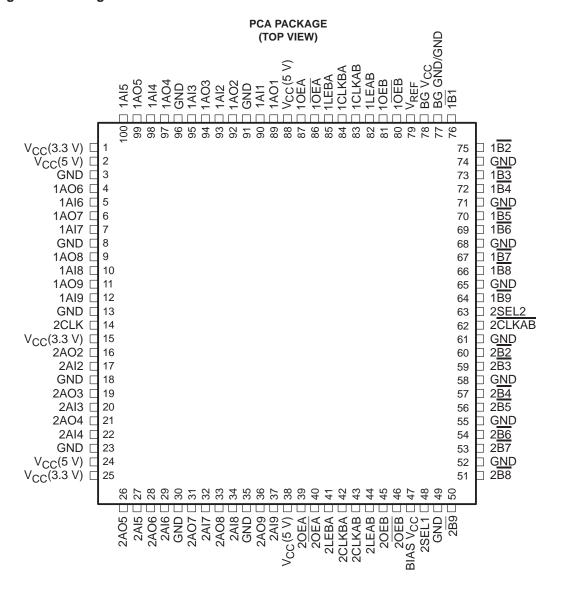
SCBS702H - AUGUST 1997 - REVISED MARCH 2004

- Compatible With IEEE Std 1194.1-1991 (BTL)
- LVTTL A Port, Backplane Transceiver Logic (BTL) B Port
- Open-Collector B-Port Outputs Sink 100 mA
- B-Port Biasing Network Preconditions the Connector and PC Trace to the BTL High-Level Voltage
- High-Impedance State During Power Up and Power Down
- Selectable Clock Delay
- TTL-Input Structures Incorporate Active Clamping Networks to Aid in Line Termination
- BIAS V_{CC} Minimizes Signal Distortion During Live Insertion/Withdrawal





Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



SCBS702H - AUGUST 1997 - REVISED MARCH 2004

description/ordering information

The SN74FB1653 contains an 8-bit and a 9-bit transceiver with a buffered clock. The clock and transceivers are designed to translate signals between LVTTL and BTL environments. The device is designed specifically to be compatible with IEEE Std 1194.1-1991 (BTL).

The A port operates at LVTTL signal levels. The A outputs reflect the inverse of the data at the \overline{B} port when the A-port output enable (OEA) is high. When OEA is low or when $V_{CC}(5 \text{ V})$ typically is less than 2.5 V, the A outputs are in the high-impedance state.

The \overline{B} port operates at BTL signal levels. The open-collector \overline{B} ports are specified to sink 100 mA. Two output enables (OEB and \overline{OEB}) are provided for the \overline{B} outputs. When OEB is low, \overline{OEB} is high, or $V_{CC}(5\ V)$ typically is less than 2.5 V, the \overline{B} port is turned off.

The clock-select (2SEL1 and 2SEL2) inputs are used to configure the TTL-to-BTL clock paths and delays (refer to the MUX-MODE DELAY table).

BIAS V_{CC} establishes a voltage between 1.62 V and 2.1 V on the BTL outputs when V_{CC}(5 V) is not connected.

BG V_{CC} and BG GND are the supply inputs for the bias generator.

 V_{REF} is an internally generated voltage source. It is recommended that V_{REF} be decoupled with an external 0.1- μ F capacitor.

Enhanced heat-dissipation techniques should be used when operating this device from AI to A0 at frequencies greater than 50 MHz, or from AI to \overline{B} or \overline{B} to A0 at frequencies greater than 100 MHz.

ORDERING INFORMATION

TA	PACKAGE [†]		ORDERABLE PART NUMBER	TOP-SIDE MARKING	
0°C to 70°C	TQFP - PCA	Tube	SN74FB1653PCA	FB1653	

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

Function Tables

TRANSCEIVER

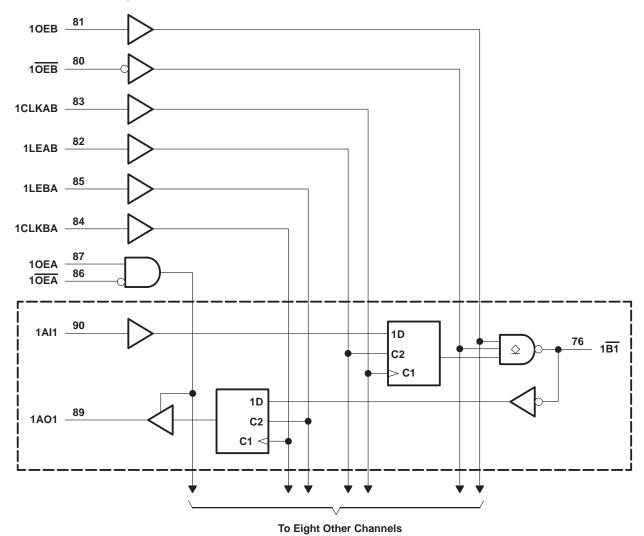
	INP	UTS		FUNCTION		
OEA	OEA	OEB	OEB	FUNCTION		
Х	Χ	Н	L	A data to B bus		
L	Н	Χ	X	B data to A bus		
L	Н	Н	L	\overline{A} data to B bus, \overline{B} data to A bus		
Х	Χ	L	Х	D have tradefine		
X	Χ	Χ	Н	B-bus isolation		
Н	Χ	Χ	Х	A bus inslation		
Х	L	Χ	Χ	A-bus isolation		

STORAGE MODE

INP	UTS	FUNCTION			
LE	CLK	FUNCTION			
Н	Х	Transparent			
L	\uparrow	Store data			
L	L	Storage			

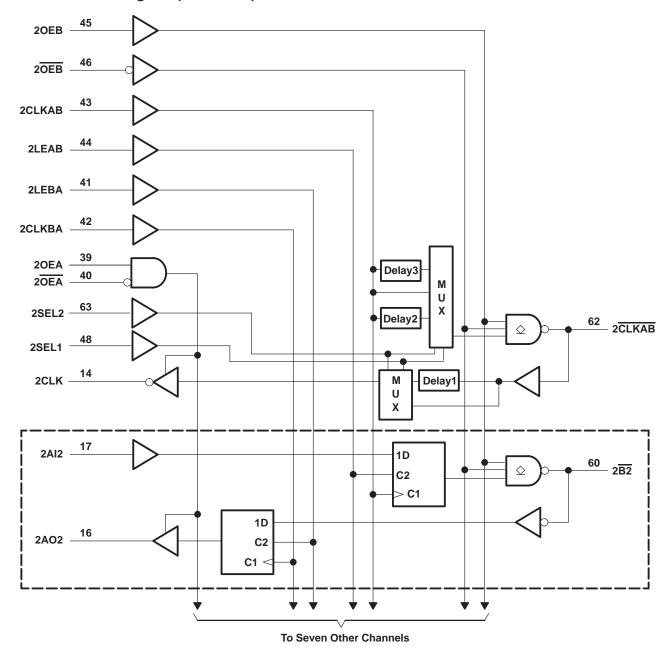


functional block diagram



SCBS702H - AUGUST 1997 - REVISED MARCH 2004

functional block diagram (continued)



MUX-MODE DELAY

INP	UTS	DELAY PATH [†]				
2SEL1	2SEL2	2CLKAB TO 2CLKAB	2CLKAB TO 2CLK			
L	L	No delay	No delay			
L	Н	No delay	Delay1			
Н	L	Delay2	Delay1			
Н	Н	Delay3	Delay1			

[†] Refer to delay1 through delay3 in the functional block diagram.



SCBS702H - AUGUST 1997 - REVISED MARCH 2004

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range: V _{CC} (5 V), BIAS V _{CC} , BG V _{CC}	–0.5 V to 7 V
V _{CC} (3.3 V)	
Input voltage range, V _I : Except B port	–1.2 V to 7 V
B port	–1.2 V to 3.5 V
Input clamp current, I _{IK} : Except B port	
B port	
Voltage range applied to any \overline{B} output in the disabled or power-off state .	–0.5 V to 3.5 V
Voltage range applied to any output in the high state	–0.5 V to V _{CC}
Current applied to any single output in the low state: A port	48 mA
B port	200 mA
Package thermal impedance, θ _{JA} (see Note 1)	22°C/W
Storage temperature range, T _{stq}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions (see Note 2)

			MIN	NOM	MAX	UNIT	
V _{CC} , BG V _{CC} , BIAS V _{CC}	Supply voltage		4.5	5	5.5	V	
V _{CC} (3.3 V)	Supply voltage		3	3.3	3.6	V	
	Ulah laval isant valta sa	B port	1.62		2.3	3	
VIH	High-level input voltage	Except B port	2			V	
.,		B port	0.75		1.47		
VIL	Low-level input voltage	Except B port			0.8	V	
liK	Input clamp current				-18	mA	
loh	High-level output current	AO port			-3	mA	
1	Lave lavel autout aumont	AO port			24	A	
lor	Low-level output current	B port			100	mA	
TA	Operating free-air temperature		0		70	°C	

NOTE 2: To ensure proper device operation, all unused inputs must be terminated as follows: A and control inputs to V_{CC}(5 V) or GND, and B inputs to GND only. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.



NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.

SN74FB1653 17-BIT LVTTL/BTL UNIVERSAL STORAGE TRANSCEIVER WITH BUFFERED CLOCK LINE SCBS702H - AUGUST 1997 - REVISED MARCH 2004

electrical characteristics over recommended operating free-air temperature range

PARAMETER		TEST CO	TEST CONDITIONS		TYP	MAX	UNIT
.,	B port	$V_{CC}(5 \text{ V}) = 4.5 \text{ V},$	I _I = -18 mA			-1.2	
VIK	Except B port	V _{CC} (3.3 V) = 3.3 V	$I_I = -40 \text{ mA}$			-0.5	V
Vон	AO port	$V_{CC}(5 \text{ V}) = 4.5 \text{ V},$ $V_{CC}(3.3 \text{ V}) = 3 \text{ V}$	I _{OH} = −3 mA	2.5			V
,,	AO port	$V_{CC}(5 \text{ V}) = 4.5 \text{ V},$ $V_{CC}(3.3 \text{ V}) = 3 \text{ V}$	I _{OL} = 24 mA		0.35	0.5	V
VOL	B port	$V_{CC}(5 \text{ V}) = 4.5 \text{ V},$	$I_{OL} = 80 \text{ mA}$	0.75		1.1	V
	ь роп	V _{CC} (3.3 V) = 3 V	$I_{OL} = 100 \text{ mA}$			1.15	
lį	Except B port	$V_{CC}(5 \text{ V}) = 5.5 \text{ V},$ $V_{CC}(3.3 \text{ V}) = 3.6 \text{ V}$	V _I = 5.5 V			50	μΑ
I _{IH} ‡	Except B port	$V_{CC}(5 \text{ V}) = 5.5 \text{ V},$ $V_{CC}(3.3 \text{ V}) = 3.6 \text{ V}$	V _I = 2.7 V			50	μΑ
. +	Except B port	$V_{CC}(5 \text{ V}) = 5.5 \text{ V},$ $V_{CC}(3.3 \text{ V}) = 3.6 \text{ V}$	V _I = 0.5 V			-50	
I _{IL} ‡	B port	V _{CC} (5 V) = 5.5 V, V _{CC} (3.3 V) = 3.6 V	V _I = 0.75 V			-100	μΑ
ЮН	B port	$V_{CC}(5 \text{ V}) = 0 \text{ to } 5.5 \text{ V},$ $V_{CC}(3.3 \text{ V}) = 3.6 \text{ V}$	V _O = 2.1 V			100	μА
I _{OZH}	AO port	$V_{CC}(5 \text{ V}) = 5.5 \text{ V},$ $V_{CC}(3.3 \text{ V}) = 3.6 \text{ V}$	V _O = 2.7 V			50	μΑ
I _{OZL}	AO port	$V_{CC}(5 \text{ V}) = 5.5 \text{ V},$ $V_{CC}(3.3 \text{ V}) = 3.6 \text{ V}$	V _O = 0.5 V			-50	μΑ
lozpu	AO port	V _{CC} = 0 to 2.1 V,	V _O = 0.5 V to 2.7 V			-50	μΑ
lozpd	AO port	$V_{CC} = 2.1 \text{ V to } 0,$	$V_0 = 0.5 \text{ V to } 2.7 \text{ V}$			-50	μΑ
	Al port to B port	., ,=,,,				145	
ICC(5 V)	B port to AO port	$V_{CC}(5 \text{ V}) = 5.5 \text{ V},$ $V_{CC}(3.3 \text{ V}) = 3.3 \text{ V}$	IO = 0			130	mA
	Outputs disabled	100(0.0 1) = 0.0 1				120	
I _{CC} (3.3 V)	B port to AO port	$V_{CC}(5 \text{ V}) = 5.5 \text{ V},$ $V_{CC}(3.3 \text{ V}) = 3.3 \text{ V}$	I _O = 0			1	mA
Ci	Control and Al inputs	V _I = 0.5 V or 2.5 V			6.5		pF
Co	AO port	V _O = 0.5 V or 2.5 V			3.5		pF
C _{iO}	B port per IEEE Std 1194.1-1991	$V_{CC}(5 \text{ V}) = 0 \text{ to } 5.5 \text{ V},$	V _{CC} (3.3 V) = 3.3 V		_	6.5	pF



[†] All typical values are at $V_{CC}(5 \text{ V}) = 5 \text{ V}$ and $V_{CC}(3.3 \text{ V}) = 3.3 \text{ V}$, $T_A = 25^{\circ}\text{C}$. ‡ For I/O ports, the parameters I_{IH} and I_{IL} include the off-state output current.

SCBS702H - AUGUST 1997 - REVISED MARCH 2004

live-insertion specifications over recommended operating free-air temperature range

PAR	AMETER		TEST CONDITIONS	MIN	MAX	UNIT
		$V_{CC}(5 \text{ V}) = 0 \text{ to } 4.5 \text{ V},$ $V_{CC}(3.3 \text{ V}) = 3.3 \text{ V}$			450	
ICC (BI	IAS V _{CC})	$V_{CC}(5 \text{ V}) = 4.5 \text{ V to } 5.5 \text{ V},$ $V_{CC}(3.3 \text{ V}) = 3.3 \text{ V}$	$V_B = 0$ to 2 V, V_I (BIAS V_{CC}) = 4.5 V to 5.5 V		10	μА
VO	B port	$V_{CC}(5 \text{ V}) = 0,$ $V_{CC}(3.3 \text{ V}) = 0 \text{ V}$	V _I (BIAS V _{CC}) = 5 V		2.1	V
		$V_{CC}(5 \text{ V}) = 0,$ $V_{CC}(3.3 \text{ V}) = 0 \text{ V}$	$V_B = 1 \text{ V},$ $V_I \text{ (BIAS V}_{CC}) = 4.5 \text{ V to } 5.5 \text{ V}$	-1		
IO B port		$V_{CC}(5 \text{ V}) = 0 \text{ to } 2.2 \text{ V},$ $V_{CC}(3.3 \text{ V}) = 3.3 \text{ V}$	OEB = 0 to 5 V		100	μΑ
		$V_{CC}(5 \text{ V}) = 0 \text{ to } 5.5 \text{ V},$ $V_{CC}(3.3 \text{ V}) = 3.3 \text{ V}$	OEB = 0 to 0.8 V		1	mA

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

			MIN	MAX	UNIT
fclock	Clock frequency			90	MHz
	Dulan duration	LE high	3		
t _W	Pulse duration	CLK high or low	3		ns
,	Setup time $ \frac{\text{Al or } \overline{\text{B}} \text{ before LE} \downarrow}{\text{Al or } \overline{\text{B}} \text{ before CLK} \uparrow} $	Al or B before LE↓	3.5		
t _{su}		Al or B before CLK↑	3.5		ns
t _h	Hald time	Al or B after LE↓	1		
	Hold time Al or B after CLK		0.7		ns

SCBS702H - AUGUST 1997 - REVISED MARCH 2004

switching characteristics over recommended operating free-air temperature range, V_{CC}(5 V) = 5 V \pm 0.5 V and V_{CC}(3.3 V) = 3.3 V (see Figure 1)

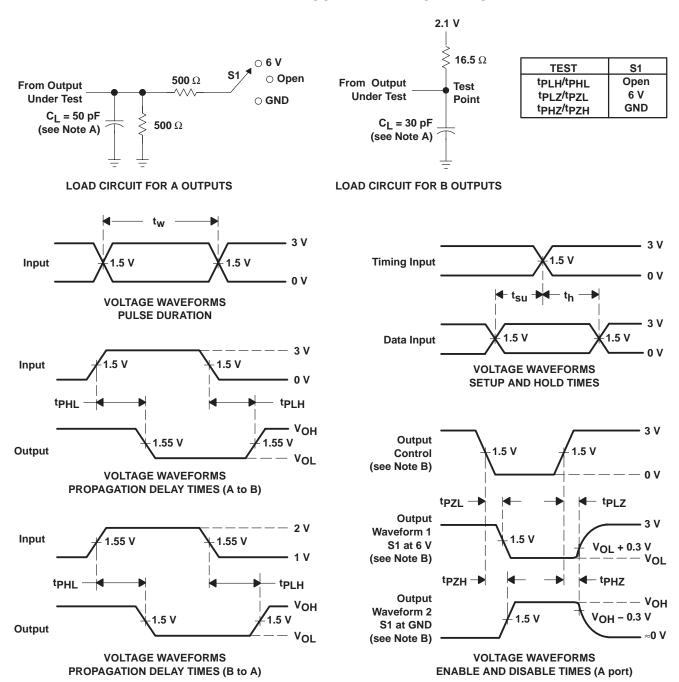
PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	MAX	UNIT
f _{max}			90		MHz
t _{PLH}		B	1.8	6.2	
^t PHL	Al	В	2.9	6.6	ns
t _{PLH}	LEAD	B	2.7	6.9	
^t PHL	LEAB	В	3.5	7.3	ns
t _{PLH}	CLKAR	B	2.3	6.4	20
^t PHL	CLKAB	Ь	2.9	6.7	ns
t _{PLH}	2CLKAB	2 <mark>CLKAB</mark>	2.3	6	20
^t PHL	(no delay)	ZCLKAB	2.9	6.7	ns
t _{PLH}	2CLKAB	2 CLKAB	4.5	9.5	20
^t PHL	(delay2)	2CLKAB	4.5	9.5	ns
t _{PLH}	2CLKAB	2 CLKAB	9.3	15.4	
^t PHL	(delay3)	ZCLKAB	9.3	15.4	ns
t _{PLH}	B	40	2	6.5	
^t PHL	В	AO	2	6.5	ns
^t PLH	LEDA	40	1.8	6.3	
^t PHL	LEBA	AO	1.8	6.3	ns
^t PLH	CLKBA	40	1.8	6.3	20
^t PHL	CLKBA	AO	1.8	6.3	ns
^t PLH	2 <mark>CLKAB</mark>	2CLK	5.7	12.3	20
^t PHL	(delay1)	ZOLK	5.7	12.3	ns
t _{PLH}	2 <mark>CLKAB</mark>	2CLK	2	6.5	no
^t PHL	(no delay)	ZOLK	2	6.5	ns
tpLH	OEB or OEB	B	2.6	7	ne
^t PHL	OLB OF OLB	В	2.6	7	ns
^t PZH	OEA or OEA	40	1.4	5.5	no
^t PZL	OEA OI OEA	AO	1.4	5.5	ns
^t PHZ	OEA or OEA	AO	1.4	6.5	no
t _{PLZ}		AO	1.4	5.8	ns
t _{sk(p)} †	Pulse skew, Al to B or B to AO			1.6	ns
'SK(p)'	Pulse skew, 2CLKAB to 2CLK			1.8	113
t _{sk(p)}	Pulse skew, CLKAB to B or CLKBA to	AO		1.5	ns
	Pulse skew, CLKAB to 2CLKAB			1.4	110
^t sk(HL) ^{, t} sk(LH) [†]	Output skew, AI to B or B to AO		1	ns	
t _{sk(o)} ‡	Output skew, nondelayed mode for 20			1	ns
	Output skew, nondelayed mode for 20		1	110	
t _{sk(o)} ‡	Output skew, nondelayed mode for 20		1.5	ns	
t.	Transition time, B outputs (1.3 V to 1.8	,	0.5	4.6	ns
t _t	Transition time, AO outputs (10% to 9	0.4	4.2	113	
t _{PR}	B-port input pulse rejection		1		ns

[†] Skew values are applicable for through mode only, with single-output switching.

^{\$} Skew values are applicable for CLK mode only, with all outputs simultaneously switching high-to-low or low-to-high.



PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: TTL inputs: PRR \leq 10 MHz, $Z_O = 50 \Omega$, $t_r \leq 2.5 \text{ ns}$, $t_f \le 2.5$ ns; BTL inputs: PRR ≤ 10 MHz, $Z_O = 50 \Omega$, $t_r \le 1$ ns, $t_f \le 1$ ns.
- D. The outputs are measured one at a time, with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms







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PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins I	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
SN74FB1653PCA	ACTIVE	HLQFP	PCA	100	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
SN74FB1653PCAG4	ACTIVE	HLQFP	PCA	100	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

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Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

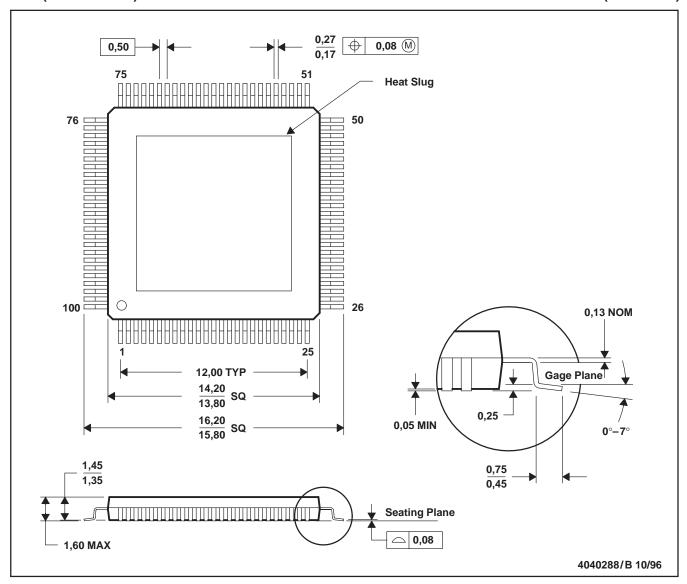
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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PCA (S-PQFP-G100)

PLASTIC QUAD FLATPACK (DIE DOWN)



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Thermally enhanced molded plastic package with a heat slug (HSL)
- D. Falls within JEDEC MS-026

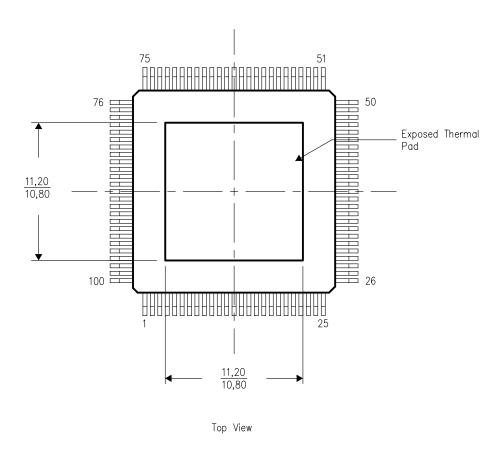


THERMAL INFORMATION

This PowerPADTM package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



NOTE: All linear dimensions are in millimeters

Exposed Thermal Pad Dimensions

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